BOURNS®

- 5 A Continuous On-State Current
- 30 A Surge-Current
- Glass Passivated Wafer
- 400 V to 800 V Off-State Voltage
- Max I_{GT} of 200 μA

This series is currently available, but not recommended for new designs.

Pin 2 is in electrical contact with the mounting base.

MDC1ACA

absolute maximum ratings over operating case temperature (unless otherwise noted)

| RATING | | SYMBOL | VALUE | UNIT | |
|--|---------|--------------------|-------------|------|--|
| | TIC106D | | 400 | | |
| Repetitive peak off-state voltage (see Note 1) | TIC106M | V | 600 | V | |
| | TIC106S | V _{DRM} | 700 | | |
| | TIC106N | | 800 | | |
| Repetitive peak reverse voltage | TIC106D | | 400 | V | |
| | TIC106M | V_{RRM} | 600 | | |
| | TIC106S | | 700 | | |
| | TIC106N | | 800 | | |
| Continuous on-state current at (or below) 80°C case temperature (see Note 2) | | | 5 | Α | |
| Average on-state current (180° conduction angle) at (or below) 80°C case temperature | | L | 3.2 | Α | |
| (see Note 3) | | I _{T(AV)} | 0.2 | | |
| Surge on-state current at (or below) 25°C (see Note 4) | | I _{TSM} | 30 | Α | |
| Peak positive gate current (pulse width ≤ 300 μs) | | I _{GM} | 0.2 | Α | |
| Peak gate power dissipation (pulse width ≤ 300 μs) | | P_{GM} | 1.3 | W | |
| Average gate power dissipation (see Note 5) | | $P_{G(AV)}$ | 0.3 | W | |
| Operating case temperature range | | T _C | -40 to +110 | °C | |
| Storage temperature range | | T _{stg} | -40 to +125 | °C | |
| Lead temperature 1.6 mm from case for 10 seconds | | T _L | 230 | °C | |

- NOTES: 1. These values apply when the gate-cathode resistance R_{GK} = 1 $k\Omega$
 - 2. These values apply for continuous dc operation with resistive load. Above 80°C derate linearly to zero at 110°C.
 - 3. This value may be applied continuously under single phase 50 Hz half-sine-wave operation with resistive load. Above 80°C derate linearly to zero at 110°C.
 - 4. This value applies for one 50 Hz half-sine-wave when the device is operating at (or below) the rated value of peak reverse voltage and on-state current. Surge may be repeated after the device has returned to original thermal equilibrium.
 - 5. This value applies for a maximum averaging time of 20 ms.



electrical characteristics at 25°C case temperature (unless otherwise noted)

| | PARAMETER | | TEST CONDITION | ONS | MIN | TYP | MAX | UNIT |
|--------------------------------------|---|---|-------------------------|---------------------------|-----|-----|-----|------|
| I _{DRM} | Repetitive peak off-state current | V _D = rated V _{DRM} | R _{GK} = 1 kΩ | T _C = 110°C | | | 400 | μА |
| I _{RRM} | Repetitive peak reverse current | V _R = rated V _{RRM} | I _G = 0 | T _C = 110°C | | | 1 | mA |
| I _{GT} | Gate trigger current | V _{AA} = 12 V | $R_L = 100 \Omega$ | t _{p(g)} ≥ 20 μs | | 5 | 200 | μΑ |
| V _{GT} Gate trigger voltage | $V_{AA} = 12 \text{ V}$ $t_{p(g)} \ge 20 \mu\text{s}$ | $R_L = 100 \Omega$ $R_{GK} = 1 k\Omega$ | T _C = - 40°C | | | 1.2 | | |
| | $V_{AA} = 12 \text{ V}$ $t_{p(g)} \ge 20 \mu\text{s}$ | $R_L = 100 \Omega$ $R_{GK} = 1 k\Omega$ | | 0.4 | 0.6 | 1 | V | |
| | $V_{AA} = 12 \text{ V}$ $t_{p(g)} \ge 20 \mu\text{s}$ | $R_L = 100 \Omega$ $R_{GK} = 1 k\Omega$ | T _C = 110°C | 0.2 | | | | |
| I _H Holding current | Holding current | $V_{AA} = 12 \text{ V}$ Initiating $I_T = 10 \text{ mA}$ | $R_{GK} = 1 k\Omega$ | T _C = - 40°C | | | 8 | mA |
| | Troiding current | $V_{AA} = 12 \text{ V}$ Initiating $I_T = 10 \text{ mA}$ | $R_{GK} = 1 k\Omega$ | | | | 5 | |
| V _T | Peak on-state voltage | I _T = 5 A | (See Note 6) | | | | 1.7 | V |
| dv/dt | Critical rate of rise of off-state voltage | V _D = rated V _D | R _{GK} = 1 kΩ | T _C = 110°C | | 10 | | V/µs |

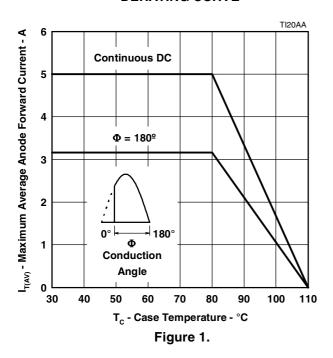
NOTE 6: This parameter must be measured using pulse techniques, $t_p = 300 \mu s$, duty cycle $\leq 2 \%$. Voltage sensing-contacts, separate from the current carrying contacts, are located within 3.2 mm from the device body.

thermal characteristics

| PARAMETER | | MIN | TYP | MAX | UNIT |
|-----------------|---|-----|-----|------|------|
| $R_{\theta JC}$ | Junction to case thermal resistance | | | 3.5 | °C/W |
| $R_{\theta JA}$ | Junction to free air thermal resistance | | | 62.5 | °C/W |

THERMAL INFORMATION

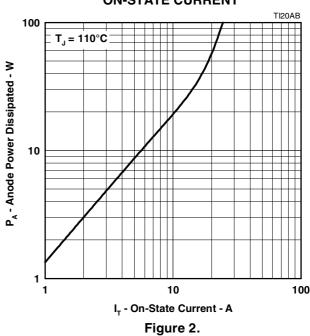
AVERAGE ANODE ON-STATE CURRENT DERATING CURVE



SURGE ON-STATE CURRENT vs

CYCLES OF CURRENT DURATION TIZOAC TO SENT TO

ANODE POWER DISSIPATED vs ON-STATE CURRENT



TRANSIENT THERMAL RESISTANCE vs

CYCLES OF CURRENT DURATION

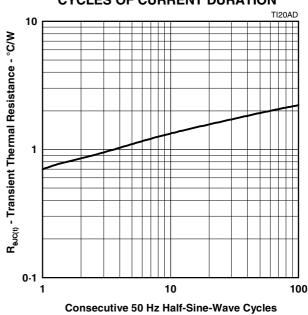
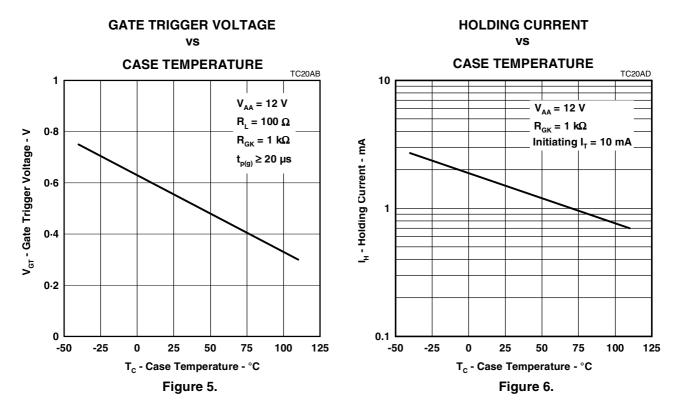


Figure 4.

TYPICAL CHARACTERISTICS



PEAK ON-STATE VOLTAGE VS PEAK ON STATE CURRENT

